

400V N-Channel MOSFET

General Features

- Proprietary New Planar Technology
- $R_{DS(ON),typ.}$ =0.24 $\Omega@V_{GS}$ =10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- Adaptor Charger
- SMPS Power Supply
- LCD Panel Power

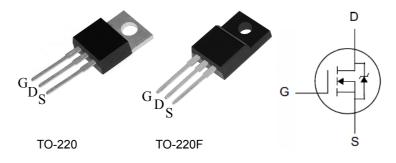
Ordering Information

Part Number	Package	Brand					
PTP20N40B	TO-220	Z					
PTA20N40B	TO-220F	Z					

Absolute Maximum Ratings

Lead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ.}	I _D
400V	0.24Ω	20A



Package No to Scale

 T_C =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	PTP20N40B	PTA20N40B	Unit	
V _{DSS}	Drain-to-Source Voltage ^[1]	400		V	
V _{GSS}	Gate-to-Source Voltage	±	30	V	
I _D	Continuous Drain Current	2	0		
I _{D @ Tc =100} ℃	Continuous Drain Current @ Tc=100℃	Figu	ire 3	Α	
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2]	Figure 6			
E _{AS}	Single Pulse Avalanche Energy	1000		mJ	
dv/dt	Peak Diode Recovery dv/dt[3]	5.0		V/ns	
D	Power Dissipation	220	50	W	
P_D	Derating Factor above 25℃	1.75	0.40	W/°C	
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260		${\mathbb C}$	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150			

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTP20N40B	PTA20N40B	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	0.57	2.5	20.11
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	100	℃ W



Electrical Characteristics

OFF Characteristics T_J =25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	400			V	V _{GS} =0V, I _D =250uA
	I _{DSS} Drain-to-Source Leakage Current			1		V _{DS} =400V, V _{GS} =0V
IDSS				100	uA	V_{DS} =320V, V_{GS} =0V, T_J =125°C
1	Cata to Source Leakage Current			+100	24	V _{GS} =+30V, V _{DS} =0V
I _{GSS}	Gate-to-Source Leakage Current			-100	nA	V _{GS} =-30V, V _{DS} =0V

ON Characteristics

T_J =25 ℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance ^[4]		0.24	0.30	Ω	V _{GS} =10V, I _D =10A
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	2.0		4.0	٧	V_{DS} = V_{GS} , I_D =250uA
gfs	Forward Transconductance ^[4]		18		S	VDS=15V,ID=10A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		2550			\/ -0\/
C _{rss}	Reverse Transfer Capacitance		33		pF	V_{GS} =0V, V_{DS} =25V, f=1.0MH _Z
C _{oss}	Output Capacitance		230			
Q_g	Total Gate Charge		35			
Q_{gs}	Gate-to-Source Charge		12		nC	V_{DD} =200V, I_{D} =20A, V_{GS} =0 to 10V
Q_{gd}	Gate-to-Drain (Miller) Charge		9.5			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		25			
trise	Rise Time		50		nS	V_{DD} =200V, I_{D} =20A,
td(OFF)	Turn-Off Delay Time		100		113	V_{GS} = 10V RG=25 Ω
t fall	Fall Time		60			



Source-Drain Body Diode Characteristics

 T_J =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[4]		I	20	۸	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[4]			80	Α	MOSFET
V _{SD}	Diode Forward Voltage		-	1.5	V	I _S =20A, V _{GS} =0V
trr	Reverse recovery time		300		ns	V _{GS} =0V ,I _F =20A,
Qrr	Reverse recovery charge		1.0		uC	dir/dt=100A/μs

Note:

^[1] T_J=+25℃ to +150℃

^[2] Repetitive rating; pulse width limited by maximum junction temperature. [3] ISD= 20A di/dt < 100 A/µs, VDD < BVDSS, TJ=+150 °C.

^[4] Pulse width≤380µs; duty cycle≤2%.



Typical Characteristics

Figure 1. Maximum Transient Thermal Impedance

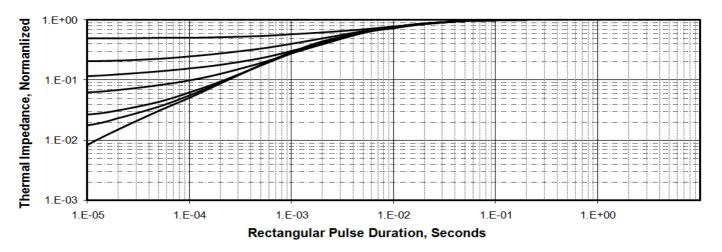


Figure 2. Max. Power Dissipation vs Case Temperature

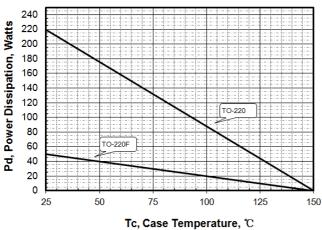


Figure 4. Output Characteristics

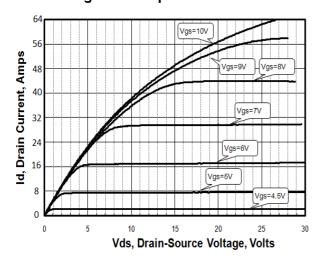


Figure 3 .Maximum Continuous Drain
Current vs Tc

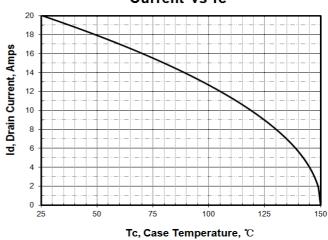
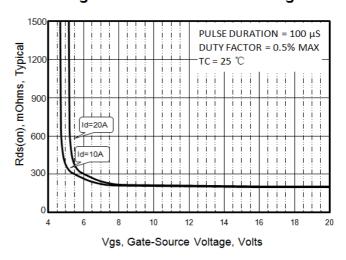


Figure 5. Rdson vs Gate Voltage





Typical Characteristics(Cont.)

Figure 6. Peak Current Capability

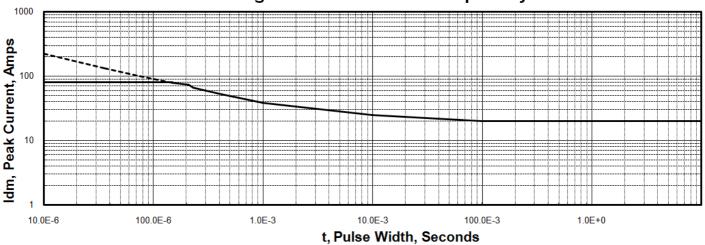


Figure 7. Transfer Characteristics

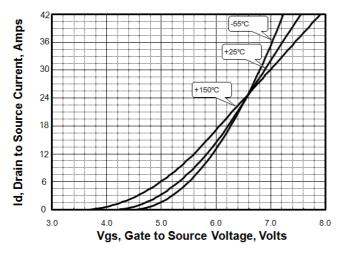


Figure 9. Drain to Source ON Resistance vs Drain Current

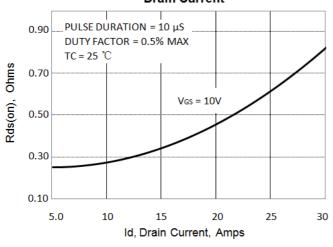


Figure 8. Unclamped Inductive Switching
Capability

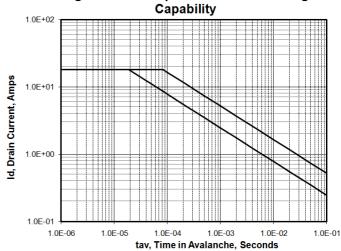
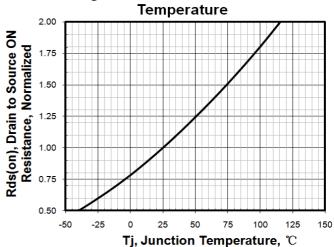


Figure 10. Rdson vs Junction





Typical Characteristics(Cont.)

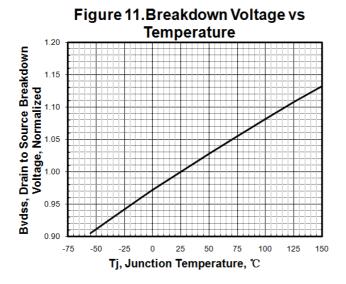


Figure 13. Maximum Safe Operating Area

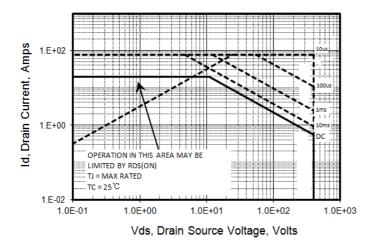


Figure 15 . Typical Gate Charge

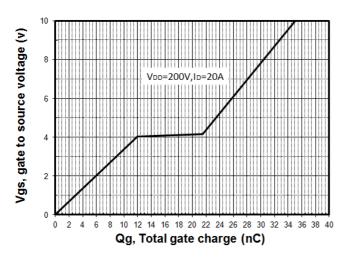


Figure 12. Threshold Voltage vs Temperature

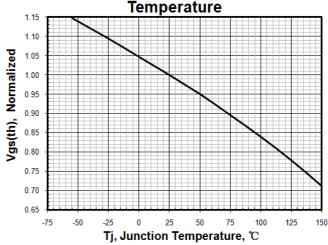


Figure 14. Capacitance vs Vds

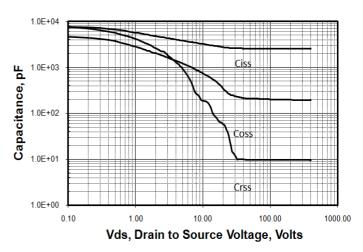
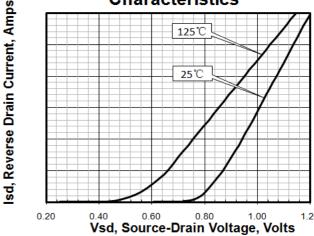


Figure 16.Body Diode Transfer Characteristics





Test Circuits and Waveforms

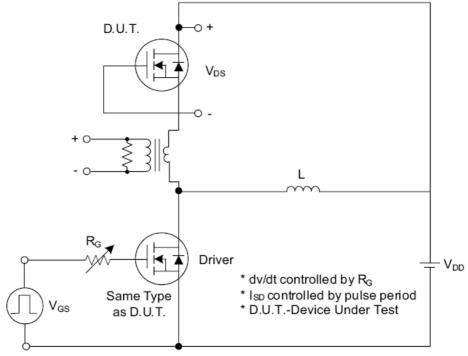


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

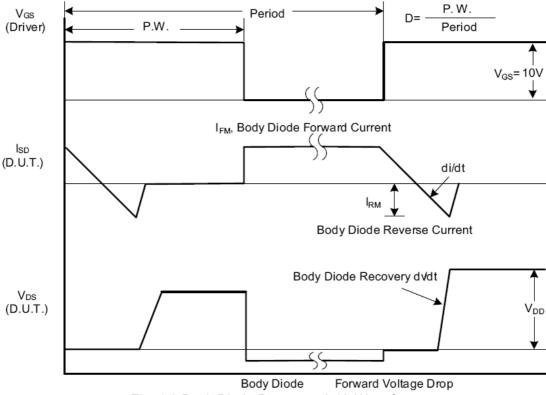


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

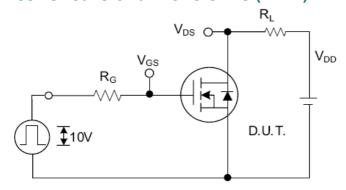


Fig. 2.1 Switching Test Circuit

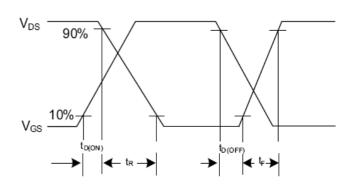


Fig. 2.2 Switching Waveforms

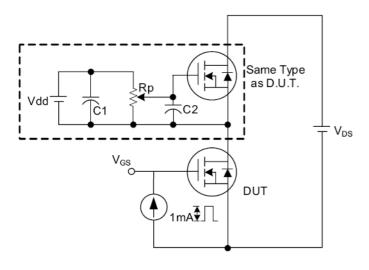


Fig. 3 . 1 Gate Charge Test Circuit

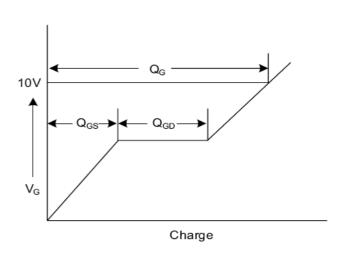


Fig. 3.2 Gate Charge Waveform

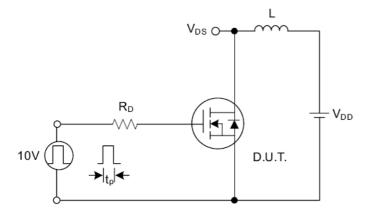


Fig. 4.1 Unclamped Inductive Switching Test Circuit

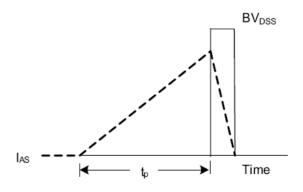


Fig. 4.2 Unclamped Inductive Switching Waveforms



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